Supplementary materials

Stabilized cubic phase $BiAgSe_{2-x}S_x$ with excellent thermoelectric properties *via* phase boundary engineering

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Composition	Theoretical Density (g/cm ³)	Measured Density (g/cm ³)	Relative Density (%)
BiAgSe _{1.2} S _{0.8}	7.79	7.23	92.81
BiAgSe _{1.1} S _{0.9}	7.67	7.45	97.13
BiAgSeS	7.52	7.47	99.34
BiAgSe _{0.9} S _{1.1}	7.42	7.39	99.60
BiAgSe _{0.8} S _{1.2}	7.29	7.14	97.94

Table S1 Densities of BiAgSe_{2-x} S_x (x = 0.8 - 1.2).



Fig. S1 Powder XRD patterns for $BiAgSe_{2,x}S_x$ (x = 0.8 - 1.2) before heating-cooling cycle (HCC). All the samples crystalline in cubic structure.



Fig. S2 Powder XRD patterns for BiAgSe_{2-x}S_x (x = 0.8 - 1.2) after one heating-cooling cycle (HCC). Only BiAgSe_{0.9}S_{1.1} and BiAgSe_{0.8}S_{1.2} were still cubic phase.



Fig. S3 Powder XRD patterns for BiAgSe_{2-x} S_x (x = 0.8 - 1.2) after two heating-cooling cycle (HCC). Only BiAgSe_{0.8} $S_{1.2}$ was still cubic phase.



Fig. S4 Lattice parameters of $BiAgSe_{2-x}S_x$ (x = 0.8 - 1.2) before heating-cooling cycle, which fit the Vegard's law well.



Fig. S5 EDS analysis of BiAgSe_{0.8}S_{1.2}.



Element	Atomic%	Normalization
S	23.71	0.90
Se	24.55	0.93
Ag	26.49	1.00
Bi	25.25	0.95
Total	100.00	/

Fig. S6 EDS analysis of BiAgSeS.



Fig. S7 Temperature-dependent total thermal conductivity, lattice thermal conductivity and electronic thermal conductivity of BiAgSe_{0.8}S_{1.2}.



Fig. S8 Repeatedly measured temperature-dependence of (a) electrical conductivity, (b) Seebeck coefficient, (c) power factor, (d) total thermal conductivity, (e) lattice thermal conductivity and (f) ZT for cubic BiAgSe_{0.8}S_{1.2}.